

N-Channel Enhancement Mode MOSFET

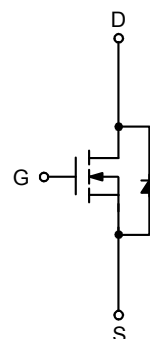
Features

- 40V/67A,
 $R_{DS(ON)} = 7m\Omega$ (max.) @ $V_{GS}=10V$
 $R_{DS(ON)} = 9m\Omega$ (max.) @ $V_{GS}=4.5V$
- Reliable and Rugged
- Lead Free and Green Devices Available
 (RoHS Compliant)

Pin Description



Top View of TO-251



N-Channel MOSFET

Applications

- SMPS Synchronous Rectification.
- Load Switch.
- DC-DC Conversion.

Ordering and Marking Information

SM4026NS □□□-□□□ Assembly Material Handling Code Temperature Range Package Code	Package Code UC : TO-251 Operating Junction Temperature Range C : -55 to 150 °C Handling Code TU : Tube (80ea/tube) Assembly Material G : Halogen and Lead Free Device
SM4026NS UC :  SM4026NS XXXXXX 	XXXXX - Lot Code

Note : SINOPOWER lead-free products contain molding compounds/die attach materials and 100% matte tin plate termination finish; which are fully compliant with RoHS. SINOPOWER lead-free products meet or exceed the lead-free requirements of IPC/JEDEC J-STD-020D for MSL classification at lead-free peak reflow temperature. SINOPOWER defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

SINOPOWER reserves the right to make changes to improve reliability or manufacturability without notice, and advise customers to obtain the latest version of relevant information to verify before placing orders.

Absolute Maximum Ratings ($T_A = 25^\circ\text{C}$ Unless Otherwise Noted)

Symbol	Parameter		Rating	Unit
Common Ratings				
V _{DSS}	Drain-Source Voltage		40	V
V _{GSS}	Gate-Source Voltage		±20	
T _J	Maximum Junction Temperature		150	°C
T _{STG}	Storage Temperature Range		-55 to 150	
I _S	Diode Continuous Forward Current	T _C =25°C	30	A
I _D	Continuous Drain Current	T _C =25°C	67	
		T _C =100°C	42	
I _{DM} ^a	Pulsed Drain Current	T _C =25°C	200	
P _D	Maximum Power Dissipation	T _C =25°C	54	W
		T _C =100°C	21	
R _{θJC}	Thermal Resistance-Junction to Case	Steady State	2.3	°C/W
I _D	Continuous Drain Current	T _A =25°C	14	A
		T _A =70°C	11	
P _D	Maximum Power Dissipation	T _A =25°C	2.5	W
		T _A =70°C	1.6	
R _{θJA} ^c	Thermal Resistance-Junction to Ambient	t ≤ 10s	20	°C/W
		Steady State	50	
I _{AS} ^b	Avalanche Current, Single pulse	L=0.5mH	18	A
E _{AS} ^b	Avalanche Energy, Single pulse	L=0.5mH	81	mJ

Note a : Pulse width limited by max. junction temperature.

Note b : UIS tested and pulse width limited by maximum junction temperature 150°C (initial temperature $T_J = 25^\circ\text{C}$).

Note c : Surface Mounted on 1in^2 pad area, steady state $t = 999\text{s}$.

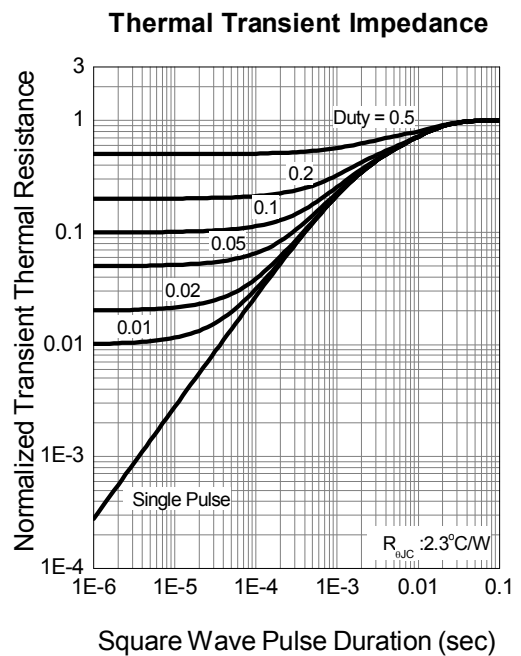
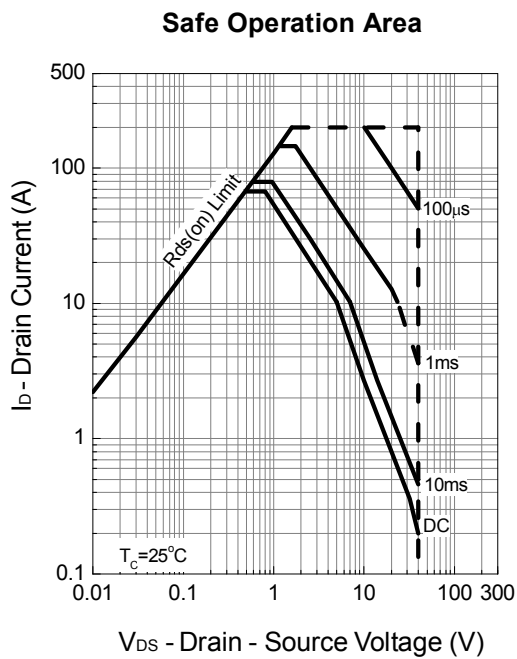
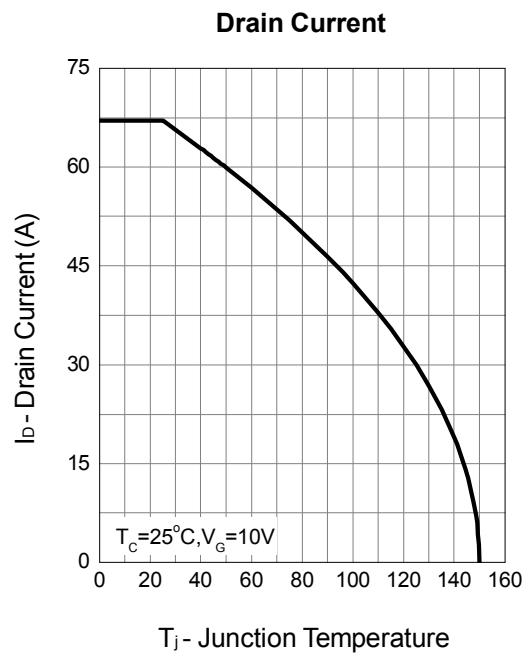
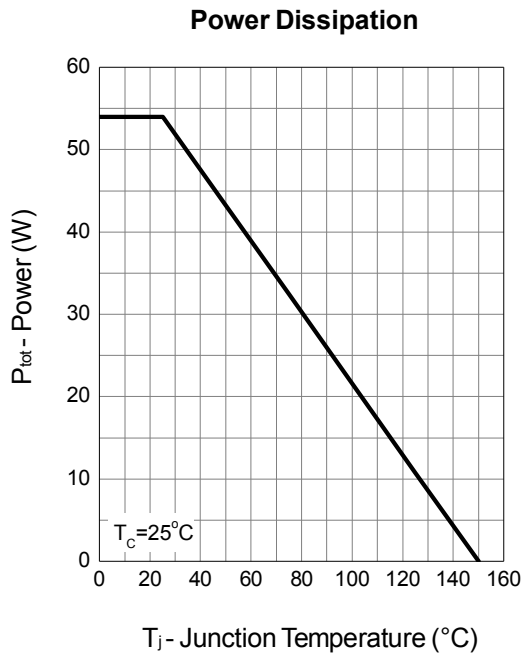
Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
Static Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _{DS} =250μA	40	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =32V, V _{GS} =0V T _J =85°C	-	-	1 30	μA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250μA	1.5	1.8	2.5	V
I _{GSS}	Gate Leakage Current	V _{GS} =±20V, V _{DS} =0V	-	-	±100	nA
R _{DS(ON)} ^d	Drain-Source On-state Resistance	V _{GS} =10V, I _{DS} =20A T _J =125°C	-	5.8 9.2	7 -	mΩ
		V _{GS} =4.5V, I _{DS} =10A	-	7	9	
Gfs	Forward Transconductance	V _{DS} =5V, I _D =10A	-	45	-	S
Diode Characteristics						
V _{SD} ^d	Diode Forward Voltage	I _{SD} =20A, V _{GS} =0V	-	0.75	1.1	V
t _{rr}	Reverse Recovery Time	I _F =20A, di _{SD} /dt=100A/μs	-	7.7	-	ns
t _a	Charge Time		-	4.1	-	
t _b	Discharge Time		-	3.6	-	
Q _{rr}	Reverse Recovery Charge		-	1.3	-	nC
Dynamic Characteristics ^e						
R _G	Gate Resistance	V _{GS} =0V, V _{DS} =0V, F=1MHz	1	2.3	3	Ω
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =20V, Frequency=1.0MHz	-	1650	-	pF
C _{oss}	Output Capacitance		-	190	-	
C _{rss}	Reverse Transfer Capacitance		-	130	-	
t _{d(ON)}	Turn-on Delay Time	V _{DD} =20V, R _L =20Ω, I _{DS} =1A, V _{GEN} =10V, R _G =1Ω	-	14	-	ns
t _r	Turn-on Rise Time		-	10	-	
t _{d(OFF)}	Turn-off Delay Time		-	43	-	
t _f	Turn-off Fall Time		-	14	-	
Gate Charge Characteristics ^e						
Q _g	Total Gate Charge	V _{DS} =20V, V _{GS} =10V, I _{DS} =20A	-	31.8	44.5	nC
Q _g	Total Gate Charge	V _{DS} =20V, V _{GS} =4.5V, I _{DS} =20A	-	14.8	-	
Q _{gth}	Threshold Gate Charge		-	3.2	-	
Q _{gs}	Gate-Source Charge		-	6.4	-	
Q _{gd}	Gate-Drain Charge		-	5.6	-	

Note d : Pulse test ; pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.

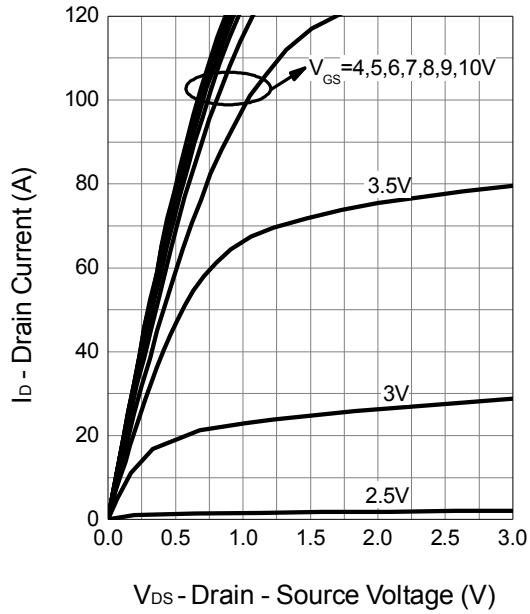
Note e : Guaranteed by design, not subject to production testing.

Typical Operating Characteristics

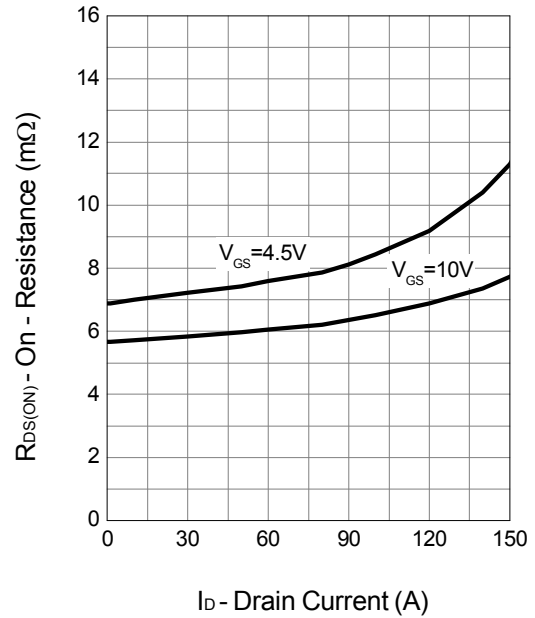


Typical Operating Characteristics (Cont.)

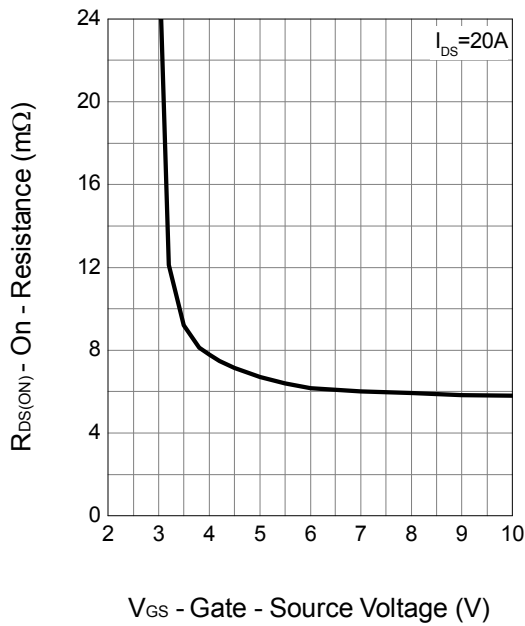
Output Characteristics



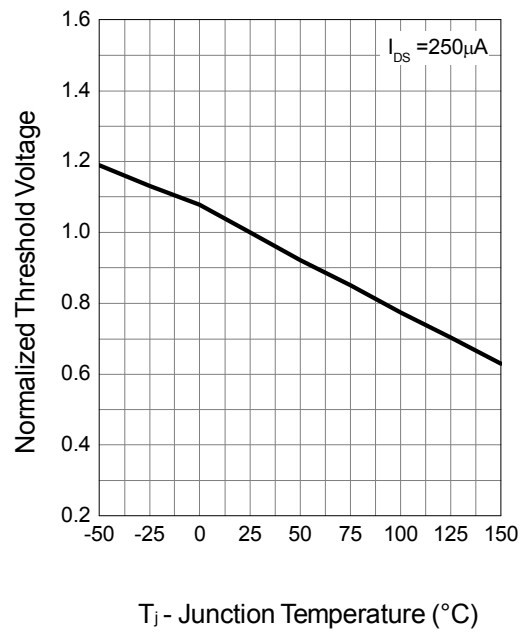
Drain-Source On Resistance



Transfer Characteristics

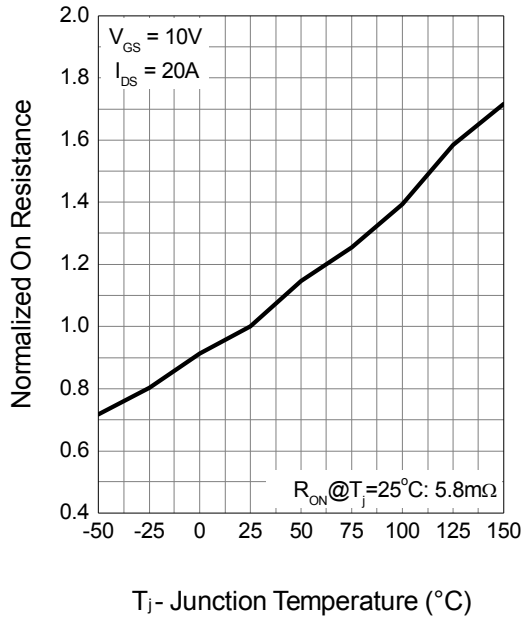


Gate Threshold Voltage

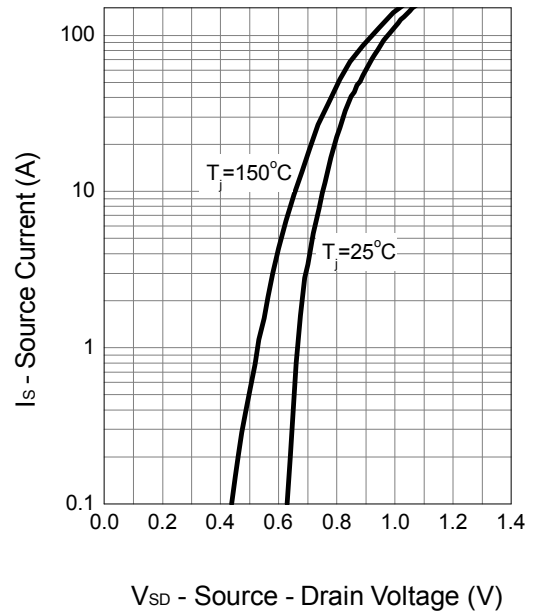


Typical Operating Characteristics (Cont.)

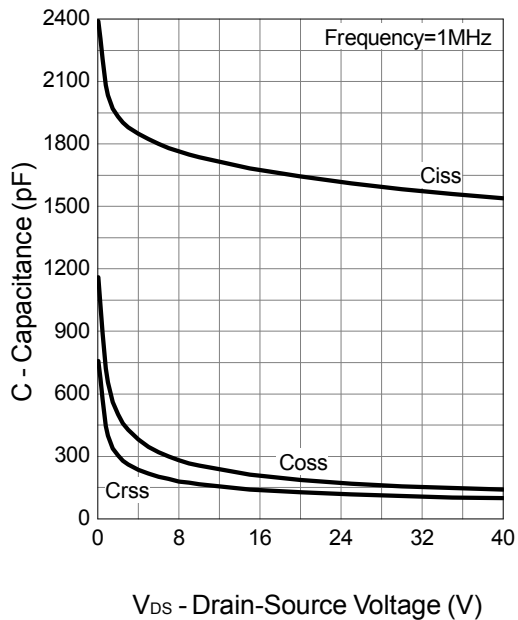
Drain-Source On Resistance



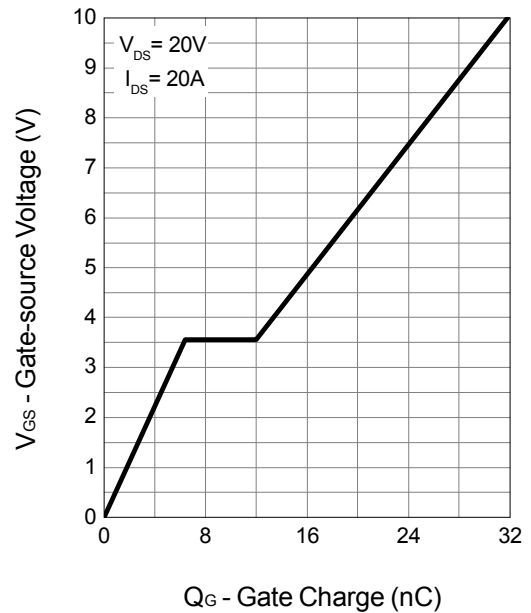
Source-Drain Diode Forward



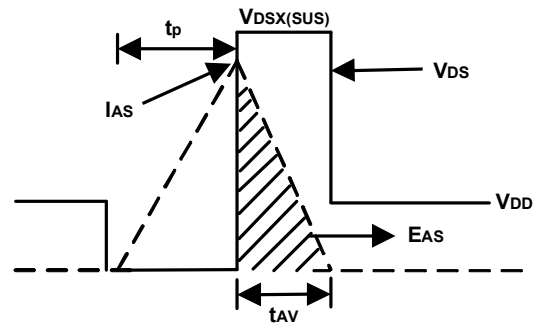
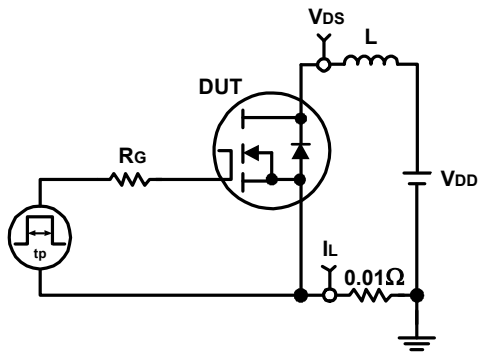
Capacitance



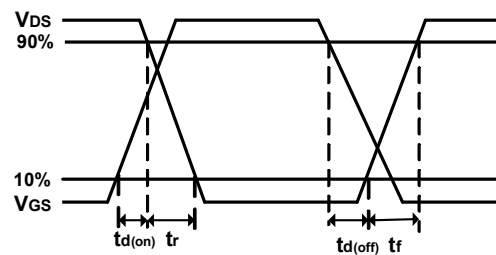
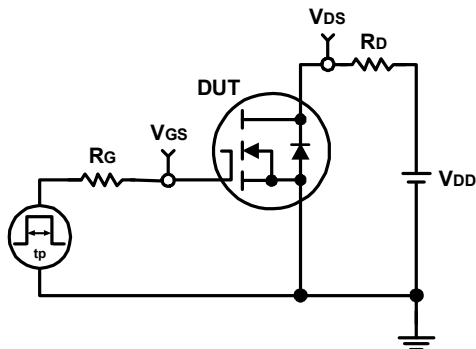
Gate Charge



Avalanche Test Circuit and Waveforms

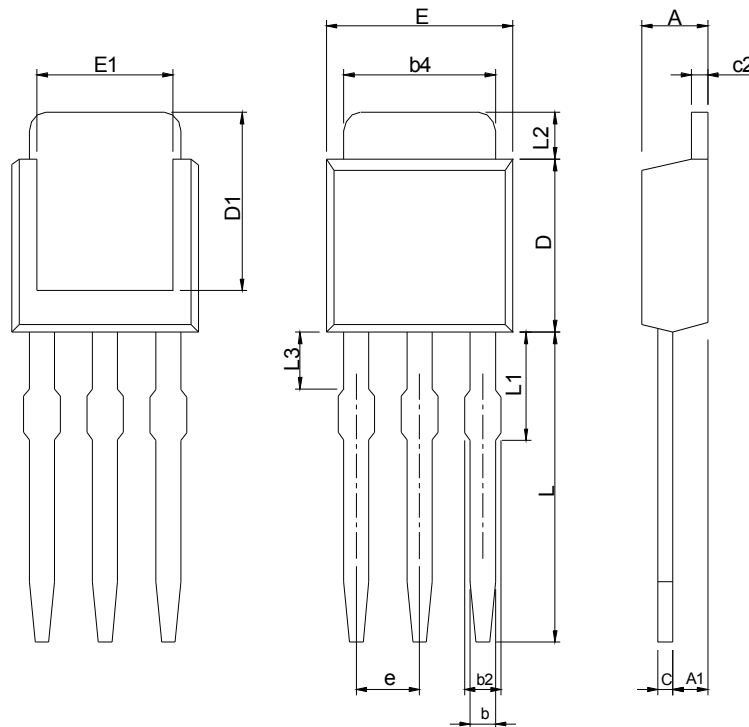


Switching Time Test Circuit and Waveforms



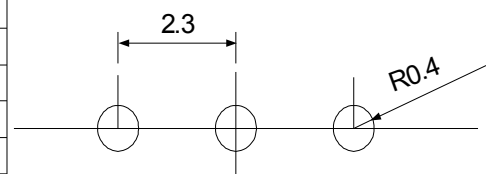
Package Information

TO-251



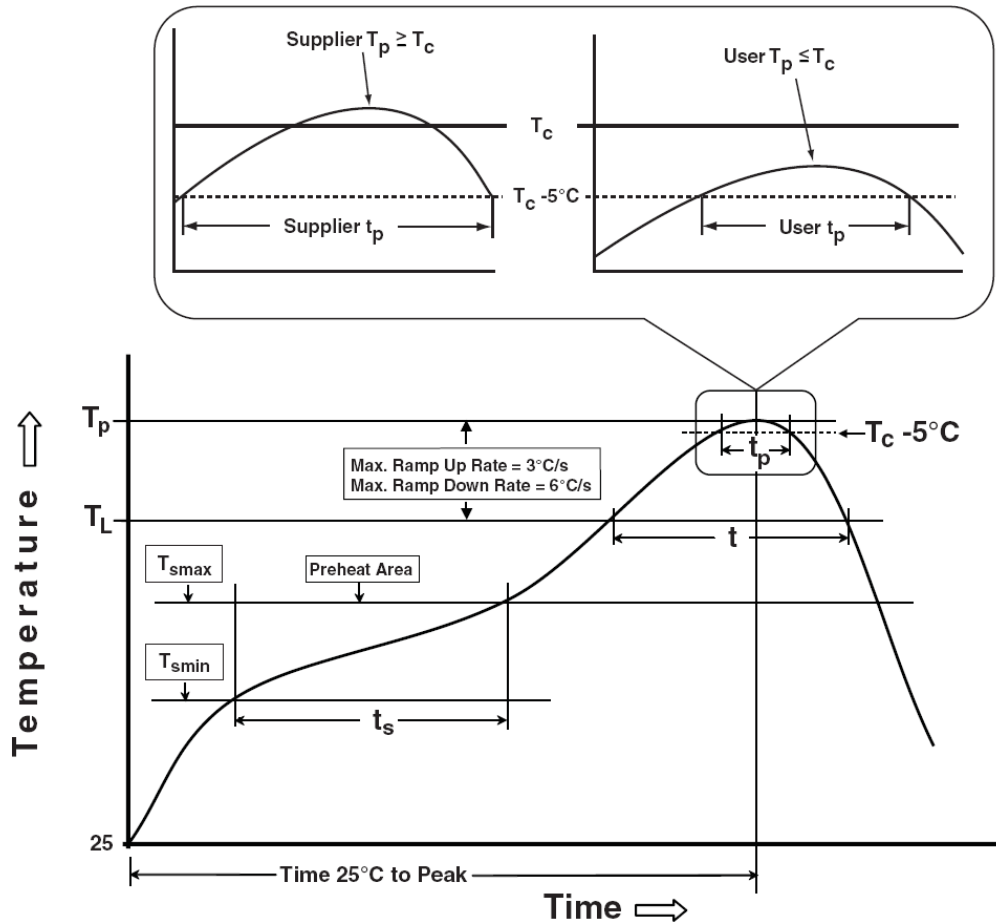
SYMBOL	TO-251(AC)			
	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	2.10	2.50	0.083	0.098
A1	0.89	1.14	0.035	0.045
b	0.40	0.89	0.016	0.035
b2	0.50	1.14	0.020	0.045
b4	4.80	5.46	0.189	0.215
c	0.35	0.65	0.014	0.026
c2	0.40	0.89	0.016	0.035
D	5.30	6.22	0.209	0.245
D1	4.90	-	0.193	-
E	6.30	6.73	0.248	0.265
E1	4.32	-	0.170	-
e	2.29 BSC		0.090 BSC	
L	3.20	3.80	0.126	0.150
L1	1.40	2.29	0.055	0.090
L2	0.89	1.70	0.035	0.067
L3	0.50	1.52	0.020	0.060

RECOMMENDED LAND PATTERN



UNIT: mm

Classification Profile



Classification Reflow Profiles

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Preheat & Soak Temperature min (T_{smin}) Temperature max (T_{smax}) Time (T_{smin} to T_{smax}) (t_s)	100 °C 150 °C 60-120 seconds	150 °C 200 °C 60-120 seconds
Average ramp-up rate (T_{smax} to T_p)	3 °C/second max.	3°C/second max.
Liquidous temperature (T_L) Time at liquidous (t_L)	183 °C 60-150 seconds	217 °C 60-150 seconds
Peak package body Temperature (T_p)*	See Classification Temp in table 1	See Classification Temp in table 2
Time (t_p)** within 5°C of the specified classification temperature (T_c)	20** seconds	30** seconds
Average ramp-down rate (T_p to T_{smax})	6 °C/second max.	6 °C/second max.
Time 25°C to peak temperature	6 minutes max.	8 minutes max.
* Tolerance for peak profile Temperature (T_p) is defined as a supplier minimum and a user maximum. ** Tolerance for time at peak profile temperature (t_p) is defined as a supplier minimum and a user maximum.		

Table 1. SnPb Eutectic Process – Classification Temperatures (T_c)

Package Thickness	Volume mm ³ <350	Volume mm ³ ≥350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2. Pb-free Process – Classification Temperatures (T_c)

Package Thickness	Volume mm ³ <350	Volume mm ³ 350-2000	Volume mm ³ >2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

Reliability Test Program

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HTRB	JESD-22, A108	1000 Hrs, 80% of VDS max @ T_{jmax}
HTGB	JESD-22, A108	1000 Hrs, 100% of VGS max @ T_{jmax}
PCT	JESD-22, A102	168 Hrs, 100%RH, 2atm, 121°C
TCT	JESD-22, A104	500 Cycles, -65°C~150°C

Customer Service

Sinopower Semiconductor, Inc.

5F, No. 6, Dusing 1St Rd., Hsinchu Science Park,

Hsinchu, 30078, Taiwan

TEL: 886-3-5635818 Fax: 886-3-5642050